

EXPEDITED PROCEDURE – EXAMINING GROUP 2117

S/N 10/612,293

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Daniel A. Day

Examiner: Phung M. Chung

Serial No.: 10/612,293

Group Art Unit: 2117

Filed: June 30, 2003

Docket No.: 884.879US1

Title: Selective Control of Test-Access Ports in Integrated Circuits

Customer Number: 21186

AMENDMENT & RESPONSE UNDER 37 C.F.R. 1.116

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In response to the Final Office Action mailed May 1, 2007, please amend the application as follows:

*ok to enter
qmc
7/16/07*

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